Search Notes		
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/659,568	CHEN ET AL.	
Examiner	Art Unit	
Amelia Rutledge	2176	:

	SEAR	CHED	
Class	Subclass	Date	Examiner
715	512	2/15/2006	AR
715	512	8/2/2006	AR
715	512	10/20/2006	AR
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Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST(US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)See Search History Printout; updated 8/2/06; 10/20/06	2/15/2006	AR
ACM Digital Library search - see search printouts	2/15/2006	AR
IEEE Xplore database search	2/15/2006	AR
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